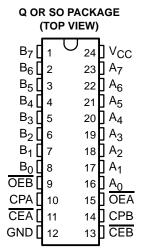
CY29FCT52T 8-BIT REGISTERED TRANSCEIVER

SCCS010A - MAY 1994 - REVISED OCTOBER 2001

- Function, Pinout, and Drive Compatible With FCT, F Logic, and AM2952
- Reduced V_{OH} (Typically = 3.3 V) Versions of Equivalent FCT Functions
- Edge-Rate Control Circuitry for Significantly Improved Noise Characteristics
- ESD Protection Exceeds JESD 22
 - 2000-V Human-Body Model (A114-A)
 - 200-V Machine Model (A115-A)
 - 1000-V Charged-Device Model (C101)
- I_{off} Supports Partial-Power-Down Mode Operation
- Matched Rise and Fall Times
- Fully Compatible With TTL Input and Output Logic Levels
- 64-mA Output Sink Current
 32-mA Output Source Current



description

The CY29FCT52T has two 8-bit back-to-back registers that store data flowing in both directions between two bidirectional buses. Separate clock, clock enable, and 3-state output-enable signals are provided for each register. Both A outputs and B outputs are specified to sink 64 mA.

This device is fully specified for partial-power-down applications using I_{off}. The I_{off} circuitry disables the outputs, preventing damaging current backflow through the device when it is powered down.

PIN DESCRIPTION

NAME	DESCRIPTION							
Α	A register inputs or B register outputs							
В	B register inputs or A register outputs							
CPA	Clock for the A register. When CEA is low, data enters the A register on the low-to-high transition of the CPA signal.							
CEA	Clock enable for the A register. When CEA is low, data enters the A register on the low-to-high transition of the CPA signal. When is high, the A register holds its contents, regardless of CPA signal transitions.							
OEA	Output enable for the A register. When OEA is low, the A register outputs are enabled onto the B lines. When OEA is high, the A output are in the high-impedance state.							
СРВ	Clock for the B register. When CEB is low, data enters the B register on the low-to-high transition of the CPB signal.							
CEB	Clock enable for the B register. When CEB is low, data enters the B register on the low-to-high transition of the CPB signal. When CEB is high, the B register holds its contents, regardless of CPA signal transitions.							
OEB	Output enable for the B register. When OEB is low, the B register outputs are enabled onto the A lines. When OEB is high, the B outputs are in the high-impedance state.							



Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.



ORDERING INFORMATION

TA	PAC	CKAGET	SPEED (ns)	ORDERABLE PART NUMBER	TOP-SIDE MARKING
	QSOP – Q	Tape and reel	6.3	CY29FCT52CTQCT	29FCT52C
–40°C to 85°C			6.3	CY29FCT52CTSOC	20505520
	SOIC – SO	Tape and reel	6.3	CY29FCT52CTSOCT	29FCT52C

[†] Package drawings, standard packing quantities, thermal data, symbolization, and PCB design guidelines are available at www.ti.com/sc/package.

Function Tables

FUNCTION TABLE

	INPUTS		INTERNAL	FUNCTION
D	СР	CE	Q	FUNCTION
Х	Х	Н	NC	Hold data
L		L	L	Load data
Н		L	Н	Load data

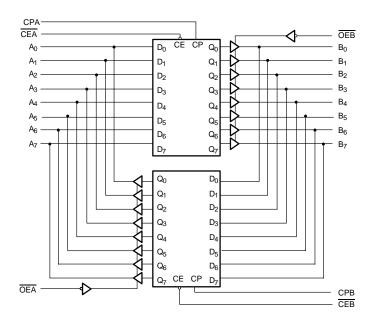
H = High logic level, L = Low logic level, X = Don't care, NC = No change

OUTPUT CONTROL

ŌĒ	INTERNAL Q	Y OUTPUTS	FUNCTION
Н	Х	Z	Disable outputs
L	L	L	Enoble sutnute
L	Н	Н	Enable outputs

H = High logic level, L = Low logic level, X = Don't care, Z = High impedance (off) state.

logic diagram





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absolute maximum rating over operating free-air temperature range (unless otherwise noted)†

Supply voltage range to ground potential		0.5 V to 7 V
DC input voltage range		–0.5 V to 7 V
DC output voltage range		0.5 V to 7 V
DC output current (maximum sink current/	pin)	120 mA
Package thermal impedance, θ _{JA} (see No	te 1): Q package	61°C/W
	SO package	46°C/W
Ambient temperature range with power ap	plied, T _A	–65°C to 135°C
Storage temperature range, T _{stq}		65°C to 150°C

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

recommended operating conditions (see Note 2)

		MIN	NOM	MAX	UNIT
VCC	Supply voltage	4.75	5	5.25	V
VIH	High-level input voltage	2			V
V _{IL}	Low-level input voltage			8.0	٧
ЮН	High-level output current			-32	mA
loL	Low-level output current			64	mA
TA	Operating free-air temperature	-40		85	°C

NOTE 2: All unused inputs of the device must be held at V_{CC} or GND to ensure proper device operation.

NOTE 1: The package thermal impedance is calculated in accordance with JESD 51-7.

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electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER		TEST CONDITIONS	MIN	TYP [†]	MAX	UNIT		
VIK	$V_{CC} = 4.75 \text{ V},$	$V_{CC} = 4.75 \text{ V}, \qquad I_{IN} = -18 \text{ mA}$						
Va	Vaa 475 V	I _{OH} = -32 mA		2			٧	
VOH	V _{CC} = 4.75 V	$I_{OH} = -15 \text{ mA}$		2.4	3.3		V	
VOL	$V_{CC} = 4.75 \text{ V},$	I _{OL} = 64 mA			0.3	0.55	V	
V _H	All inputs				0.2		V	
lμ	$V_{CC} = 5.25 \text{ V},$	$V_{IN} = V_{CC}$				5	μΑ	
lін	$V_{CC} = 5.25 \text{ V},$	$V_{IN} = 2.7 \text{ V}$				±1	μΑ	
I _{IL}	$V_{CC} = 5.25 \text{ V},$	V _{IN} = 0.5 V				±1	μΑ	
los [‡]	V _{CC} = 5.25 V,	V _{OUT} = 0 V		-60	-120	-225	mA	
l _{off}	$V_{CC} = 0 V$,			±1	μΑ			
Icc	$V_{CC} = 5.25 \text{ V}, V_{IN} \le 0.25 \text{ V}$	$V_{CC} = 5.25 \text{ V}, V_{IN} \le 0.2 \text{ V}, V_{IN} \ge V_{CC} - 0.2 \text{ V}$						
ΔlCC	V _{CC} = 5.25 V, V _{IN} = 3	.4 V\$, f ₁ = 0, Outputs ope	n		0.5	2	mA	
ICCD¶	V _{CC} = 5.25 V, One inp OEA or OEB = GND, V	ut switching at 50% duty of $I_{N} \le 0.2 \text{ V or } V_{IN} \ge V_{CC}$	cycle, Outputs open, – 0.2 V		0.06	0.12	mA/ MHz	
	V _{CC} = 5.25 V,	One bit switching at f ₁ = 5 MHz	$V_{IN} \le 0.2 \text{ V or}$ $V_{IN} \ge V_{CC} - 0.2 \text{ V}$		0.7	1.4		
lc#	$f_0 = 10 \text{ MHz},$	at 50% duty cycle	$V_{IN} = 3.4 \text{ V or GND}$		1.2	3.4	mA	
IC"	Outputs open, OEA or OEB = GND	Eight bits switching at f ₁ = 2.5 MHz	$V_{IN} \le 0.2 \text{ V or}$ $V_{IN} \ge V_{CC} - 0.2 \text{ V}$		1.6	3.2	mA	
		at 50% duty cycle	$V_{IN} = 3.4 \text{ V or GND}$		3.9	12.2		
C _i					5	10	pF	
Co					9	12	pF	

[†] Typical values are at $V_{CC} = 5 \text{ V}$, $T_A = 25^{\circ}\text{C}$.

 $^{\#}$ IC = ICC + \triangle ICC \times DH \times NT + ICCD (f₀/2 + f₁ \times N₁)

Where:

I_C = Total supply current

I_{CC} = Power-supply current with CMOS input levels

 ΔI_{CC} = Power-supply current for a TTL high input ($V_{IN} = 3.4 \text{ V}$)

 D_H = Duty cycle for TTL inputs high N_T = Number of TTL inputs at D_H

ICCD = Dynamic current caused by an input transition pair (HLH or LHL)

f₀ = Clock frequency for registered devices, otherwise zero

f₁ = Input signal frequency

N₁ = Number of inputs changing at f₁

All currents are in milliamperes and all frequencies are in megahertz.

Values for these conditions are examples of the ICC formula.



Not more than one output should be shorted at a time. Duration of short should not exceed one second. The use of high-speed test apparatus and/or sample-and-hold techniques are preferable to minimize internal chip heating and more accurately reflect operational values. Otherwise, prolonged shorting of a high output can raise the chip temperature well above normal and cause invalid readings in other parametric tests. In any sequence of parameter tests, I_{OS} tests should be performed last.

[§] Per TTL driven input (V_{IN} = 3.4 V); all other inputs at V_{CC} or GND

This parameter is derived for use in total power-supply calculations.

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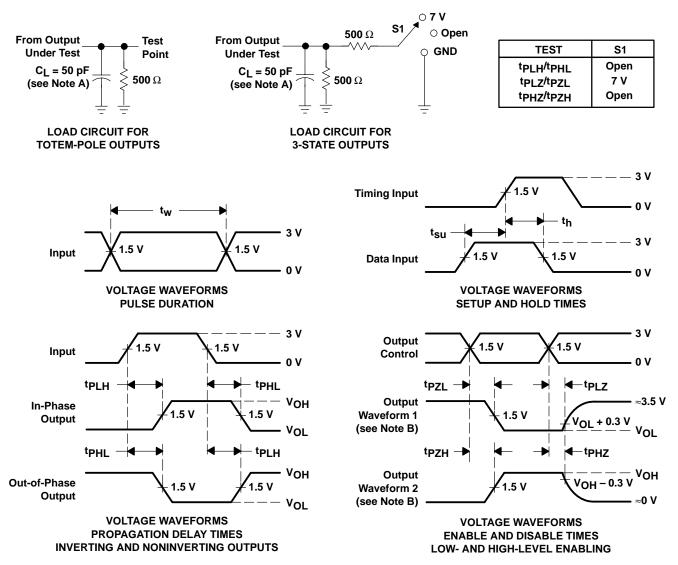
timing requirements over recommended operating free-air temperature range (unless otherwise noted) (see Figure 1)

	PARAMETER						
t _W	3		ns				
_	Catura tima hatara CDAA an CDDA	Data	2.5				
t _{su}	Setup time, before CPA↑ or CPB↑	3		ns			
Ĺ.	Hold time, after CPA↑ or CPB↑	Data	1.5				
th	Hold time, after CPAT of CPBT	2		ns			

switching characteristics over operating free-air temperature range (see Figure 1)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	MIN	MAX	UNIT
t _{PLH}	CPA, CPB	A, B	2	6.3	no
tPHL	CPA, CPB	А, Б	2	6.3	ns
^t PZH	OEA or OEB	A or B	1.5	7	ne
^t PZL	OEA 01 OEB	AUB	1.5	7	ns
^t PHZ	OEA or OEB	A or B	1.5	6.5	ns
t _{PLZ}	OEA 01 OEB	A 01 B	1.5	6.5	115

PARAMETER MEASUREMENT INFORMATION



NOTES: A. C_L includes probe and jig capacitance.

- B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
- C. The outputs are measured one at a time with one input transition per measurement.

Figure 1. Load Circuit and Voltage Waveforms



PACKAGE OPTION ADDENDUM

www.ti.com 11-Nov-2009

PACKAGING INFORMATION

Orderable Device	Status ⁽¹⁾	Package Type	Package Drawing	Pins	Package Qty	e Eco Plan ⁽²⁾	Lead/Ball Finish	MSL Peak Temp ⁽³⁾
CY29FCT52CTQCT	ACTIVE	SSOP/ QSOP	DBQ	24	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR
CY29FCT52CTQCTE4	ACTIVE	SSOP/ QSOP	DBQ	24	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR
CY29FCT52CTQCTG4	ACTIVE	SSOP/ QSOP	DBQ	24	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR
CY29FCT52CTSOC	ACTIVE	SOIC	DW	24	25	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
CY29FCT52CTSOCE4	ACTIVE	SOIC	DW	24	25	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
CY29FCT52CTSOCG4	ACTIVE	SOIC	DW	24	25	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM

⁽¹⁾ The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

TBD: The Pb-Free/Green conversion plan has not been defined.

Pb-Free (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

Pb-Free (RoHS Exempt): This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

(3) MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

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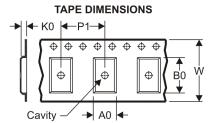
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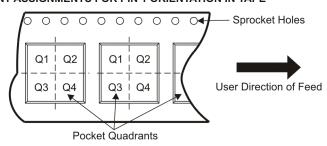
TAPE AND REEL INFORMATION





A0	Dimension designed to accommodate the component width
B0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



*All dimensions are nominal

Device	Package Type	Package Drawing			Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
CY29FCT52CTQCT	SSOP/ QSOP	DBQ	24	2500	330.0	16.4	6.5	9.0	2.1	8.0	16.0	Q1

PACKAGE MATERIALS INFORMATION

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*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
CY29FCT52CTQCT	SSOP/QSOP	DBQ	24	2500	346.0	346.0	33.0

DW (R-PDSO-G24)

PLASTIC SMALL-OUTLINE PACKAGE



NOTES:

- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold flash or protrusion not to exceed 0.006 (0,15).
- D. Falls within JEDEC MS-013 variation AD.



DBQ (R-PDSO-G24)

PLASTIC SMALL-OUTLINE PACKAGE



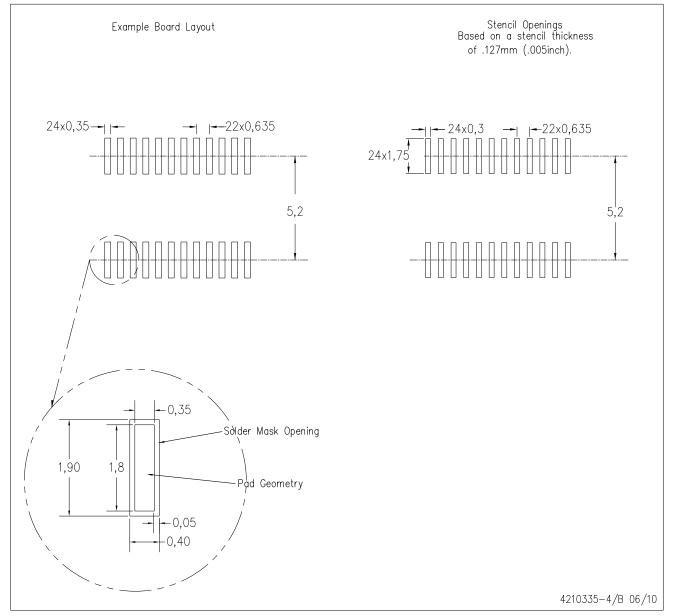
NOTES:

- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold flash or protrusion not to exceed 0.006 (0,15) per side.
- D. Falls within JEDEC MO-137 variation AE.



DBQ (R-PDSO-G24)

PLASTIC SMALL OUTLINE PACKAGE



NOTES:

- A. All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.
- C. Customers should place a note on the circuit board fabrication drawing not to alter the center solder mask defined pad.
- D. Publication IPC-7351 is recommended for alternate designs.
- E. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Example stencil design based on a 50% volumetric metal load solder paste. Refer to IPC-7525 for other stencil recommendations.



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